

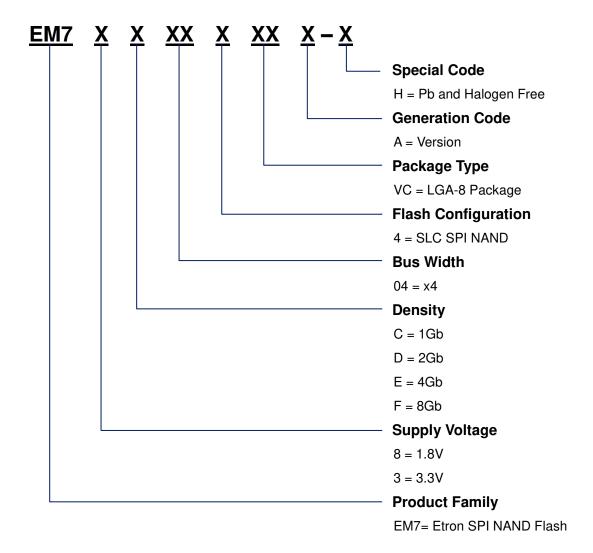
# **SPI NAND Flash Datasheet**

**Serial Peripheral Interface (SPI)** 

Model EM78E044VCA-H

## **SPI NAND Part Numbering Information**

Etron SPI NAND Flash devices are categorized in the following diagram based on the features and densities



Etron Technology, Inc. reserves the right to change products or specification without notice.

## **Revision History**

Rev	Date	Comments			
1.00	February 20, 2024	Initial release			

## **Contents**

1	Introduction	7
	1.1 Features	7
	1.2 General Description	8
	1.3 Memory Mapping Diagram	9
	1.4 ECC Protection and Spare Area	
	1.5 Pin Configuration	
2	Device Operation	
	2.1 SPI Mode	
	2.2 Hold Mode	13
	2.3 Write Protection Mode	
3	Commands Description	15
4	Write Operations	16
5	Feature Operations	
6	Read Operations	18
	6.1 Read ID (9FH)	18
	6.2 Page Read (13H)	
	6.3 Read from Cache x1 IO (03H/0BH)	
	6.4 Read from Cache x2 IO (3BH)	
	6.5 Read from Cache x4 IO (6BH)	
	6.6 Read from Cache Dual IO (BBH)	
	6.7 Read from Cache Quad IO (EBH)	
7	Program Operations	
	7.1 Program Load (PL) (02H)	
	7.2 Program Load x4 IO (PL x4) (32H)	
	7.3 Program Execute (PE) (10H)	
8	Internal Data Move	
	8.1 Program Load Random Data (84H)	
	8.2 Program Load Random Data x4 (C4H/34H)	28
_	8.3 Program Load Random Data Quad IO (72H)	29
9	Erase Operation- Block Erase (D8H)	
10	Reset Operation - Reset (FFH)	
11	One-Time Programmable (OTP) Function	
	11.1 OTP Definition	
40	11.2 Parameter Page Definition	
12	Block Protection	
13	Status Register	
14	Block Management	
15	Power-On Process Electrical Characteristics	
16 17	Package Outline Information	
1/	ralnaue vuliiie iiiviiialivii	43

## **List of Figures**

Figure 1-1. Functional Block Diagram	8
Figure 1-2. Memory Mapping Diagram	9
Figure 1-3. Pin Assignments	11
Figure 2-1. Timing Diagram of SPI Modes	12
Figure 2-2. Hold Condition Diagram	13
Figure 4-1. Write Enable (06H) Sequence Diagram	16
Figure 4-2. Write Disable (04H) Sequence Diagram	16
Figure 5-1. Get Feature (0FH) Sequence Diagram	17
Figure 5-2. Set Feature (1FH) Sequence Diagram	17
Figure 6-1. Read ID (9FH) Sequence Diagram	18
Figure 6-2. Page Read to Cache (13H) Sequence Diagram	20
Figure 6-3. Read from Cache x1 IO (03H/0BH) Sequence Diagram	20
Figure 6-4. Read from Cache x2 IO (3BH) Sequence Diagram	21
Figure 6-5. Read from Cache x4 IO (6BH) Sequence Diagram	22
Figure 6-6. Read from Cache Dual IO (BBH) Sequence Diagram	23
Figure 6-7. Read from Cache Quad (EBH) Sequence Diagram	23
Figure 7-1. Program Load (02H) Sequence Diagram	25
Figure 7-2. Program Load x4 IO (32H) Sequence Diagram	25
Figure 7-3. Program Execute (10H) Sequence Diagram	26
Figure 8-1. Program Load Random Data (84H) Sequence Diagram	27
Figure 8-2. Program Load Random Data x4 (C4H/34H) Sequence Diagram	28
Figure 8-3. Program Load Random Data Quad IO (72H) Sequence Diagram	29
Figure 9-1. Block Erase (D8H) Sequence Diagram	30
Figure 10-1. Reset (FFH) Sequence Diagram	31
Figure 15-1. Power-On Process	38
Figure 16-1. Serial Input Timing	41
Figure 16-2. Serial Output Timing	41
Figure 16-3. Hold# Timing	41
Figure 16-4. WP# Timing	42
Figure 17-1 I GA (8 x 6 x 0 8mm) Package Outline Drawing Information	44

## **List of Tables**

Table 1-1. Product Information	7
Table 1-2. ECC Protection and Spare Area	10
Table 1-3. Pin Descriptions	11
Table 3-1. SPI NAND Command Set	15
Table 5-1. Feature Register Table	17
Table 6-1. ID Definition Table	18
Table 6-2. 24-bit address consisting of dummy bits and block/page address bits	19
Гable 6-3. Wrap Bit Definition <sup>(2)</sup>	19
Table 11-1. OTP State	32
Table 11-2. OTP Page Definition	32
Table 11-3. Parameter Page Data Structure	33
Table 12-1. Block Protection Bits Table	35
Table 13-1. Status Register Bit Description	36
Table 14-1. Valid Block Information	37
Table 15-1. Power-On Process Parameters	38
Table 16-1. Capacitance Characteristics	39
Table 16-2. 1.8V SPI NAND DC Characteristics	39
Table 16-3. 1.8V AC Time Characteristics (T <sub>A</sub> = -40 ∼ 85°C, C <sub>L</sub> = 10pF)	40
Table 17-1. LGA (8 x 6 x 0.8mm) Dimension Table	43

### 1 Introduction

#### 1.1 Features

■ Single-Level Cell (SLC) NAND Flash

#### **■** Operating Voltage Support

- VCC: 1.8V (1.7V to 1.98V)

#### **■** Clock Frequency

- Up to 100MHz

#### **■** Temperature

- Operating Temperature: -40°C to +85°C

- Storage Temperature: -65°C to +150°C

#### ■ Standard, Dual and Quad SPI

- Standard SPI: SCLK, CS#, SI, SO, WP#, HOLD#

- Dual SPI: SCLK, CS#, SIO0, SIO1, WP#, HOLD#

- Quad SPI: SCLK, CS#, SIO0, SIO1, SIO2, SIO3

#### **■** ECC Protection

- 8bit ECC for each sector<sup>(1)</sup> [512bytes + 32bytes]

#### ■ Package (Pb Free and Halogen Free)

- 8-pin LGA-8 (8 x 6 x 0.8mm)

#### **■** OTP Protection

- 64 pages one time programmable

#### **■** Performance (Typical)

- Page Program Time: 600us

- Page Read Time: 140us

- Block Erase Time: 3ms

#### Operating Current

- Read Operation Current: 25mA

- Program Operation Current: 25mA

- Erase Operation Current: 30mA

- 120uA maximum standby current

#### ■ Endurance

- P/E cycles: more than 60,000/cycles

#### ■ Data Retention

- 10/years

Note1: Each page is divided into 8 Sectors, Reference the Table 1-2

#### **Table 1-1. Product Information**

Part Number	Density	VCC	ECC	Page Size	Block	Device	Package
EM78E044VCA-H	4Gbits	1.8V	8bit	4096+256 Bytes	64 Pages	2048 Blocks	LGA-8

### 1.2 General Description

SPI (Serial Peripheral Interface) NAND provides a low cost and low pin count solution to alternate SPI-NOR in high density non-volatile memory storage solution for embedded systems.

SPI NAND is a flash memory device with SLC NAND of the standard parallel NAND. The serial electrical interface follows the industry-standard serial peripheral interface. The command sets are similar to SPI-NOR command sets. Some modifications have been made for handling NAND-specific functions. Besides, new features are added to extend applications. The SPI NAND has 8 pin counts in total, including six signal lines plus VCC and GND.

Each block of the serial NAND is subdivided into 64 programmable pages. Each page consists of a data storage region and a spare area. The data storage region is used to store user-programmed data and the spare area is typically used for memory management and error correction functions.

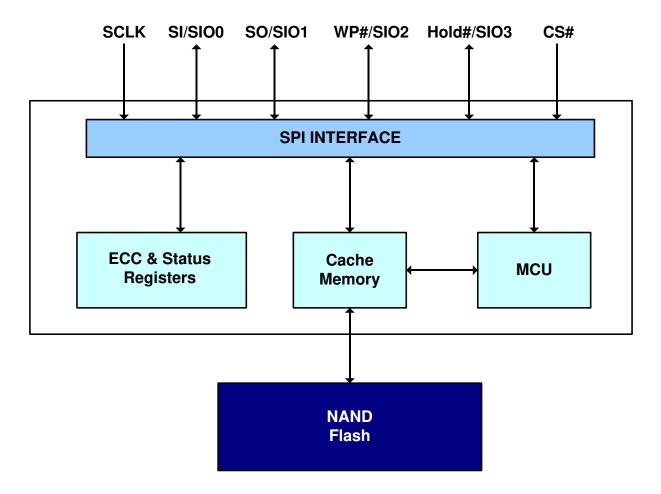


Figure 1-1. Functional Block Diagram

### 1.3 Memory Mapping Diagram

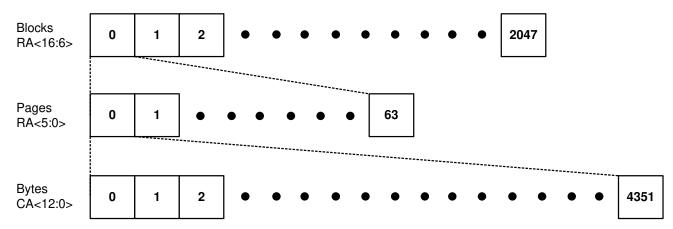


Figure 1-2. Memory Mapping Diagram

#### Notes:

- 1. CA: Column Address. The 13-bit address is capable of addressing from 0 to 8191 bytes; however, only bytes 0 through 4351 are valid. Bytes 4352 through 8191 of each page are "out of bounds" do not exist in the device, and cannot be addressed.
- 2. RA: Row Address. RA<5:0> selects a page inside a block, and RA<16:6> selects a block.

### 1.4 ECC Protection and Spare Area

**Table 1-2. ECC Protection and Spare Area** 

	Table 1-2. LOO I Totection and Spare Area						
Start Address	End Address	ECC Protected	Area	Description			
0000h	01FFh	Yes	Main Area 01	Data storage region 01			
0200h	03FFh	Yes	Main Area 02	Data storage region 02			
0400h	05FFh	Yes	Main Area 03	Data storage region 03			
0600h	07FFh	Yes	Main Area 04	Data storage region 04			
0800h	09FFh	Yes	Main Area 05	Data storage region 05			
0A00h	0BFFh	Yes	Main Area 06	Data storage region 06			
0C00h	0DFFh	Yes	Main Area 07	Data storage region 07			
0E00h	0FFFh	Yes	Main Area 08	Data storage region 08			
1000h	1003h	No <sup>(2)</sup>	Chara Araa 01	Meta data 01-1			
1004h	1011h	Yes	Spare Area 01	Meta data 01-2			
1012h	1015h	No <sup>(2)</sup>	Cooks Akss 00	Meta data 02-1			
1016h	1023h	Yes	Spare Area 02	Meta data 02-2			
1024h	1027h	No <sup>(2)</sup>	Cross Association	Meta data 03-1			
1028h	1035h	Yes	Spare Area 03	Meta data 03-2			
1036h	1039h	No <sup>(2)</sup>	Cross Asso 04	Meta data 04-1			
103Ah	1047h	Yes	Spare Area 04	Meta data 04-2			
1048h	104Bh	No <sup>(2)</sup>	Coore Area OF	Meta data 05-1			
104Ch	1059h	Yes	Spare Area 05	Meta data 05-2			
105Ah	105Dh	No <sup>(2)</sup>	Chara Araa 06	Meta data 06-1			
105Eh	106Bh	Yes	Spare Area 06	Meta data 06-2			
106Ch	106Fh	No <sup>(2)</sup>	Co. 242 A 422 07	Meta data 07-1			
1070h	107Dh	Yes	Spare Area 07	Meta data 07-2			
107Eh	1081h	No <sup>(2)</sup>	Cmara A 00	Meta data 08-1			
1082h	108Fh	Yes	Spare Area 08	Meta data 08-2			
1090h	10FFh	Yes	Spare Area 09	Internal ECC parity area <sup>(1)</sup>			

#### Notes:

- 1. When the ECC function is enabled, the internal ECC parity area only can be read, and the data is 'FF'.
- 2. The 1st to 4th bytes in the meta data are unprotected by ECC.

### 1.5 Pin Configuration

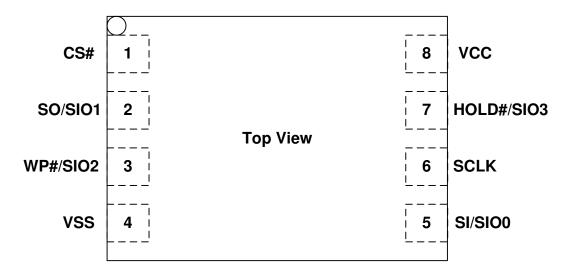


Figure 1-3. Pin Assignments

**Table 1-3. Pin Descriptions** 

Pin Name	Туре	Description
CS#	Input	Chip Select
SCLK	Input	Serial Clock
SI/SIO0	I/O	Serial Data Input / Serial Data IO0
SO/SIO1	I/O	Serial Data Output / Serial Data IO1
WP#/SIO2	I/O	Write Protect / Serial Data IO2
Hold#/SIO3	I/O	Hold / Serial Data IO3
VCC	Supply	Power Supply
VSS	Ground	Ground

## 2 Device Operation

#### 2.1 SPI Mode

SPI NAND supports two SPI modes:

- CPOL = 0, CPHA = 0 (Mode 0)
- CPOL = 1, CPHA = 1 (Mode 3)

Input data is latched in on the rising edge of SCLK and output data is available on the falling edge of SCLK for both mode 0 and mode 3. The timing diagrams shown in this data sheet are mode 0.

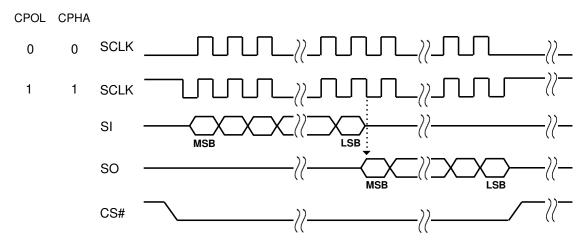


Figure 2-1. Timing Diagram of SPI Modes

#### Note:

- SCLK provides interface timing for SPI NAND. Address, data and commands are latched on the rising edge of SCLK. Data is placed on SO at the falling edge of SCLK.
- 2. When CS# is 0, the device is placed in active mode. When CS# goes 1, the device is placed in inactive mode and SO is High-Z.

#### 2.1.1 Standard SPI

Standard serial peripheral interface on four signals bus: System Clock (SCLK), Chip Select (CS#), Serial Data In (SI) and Serial Data Out (SO).

#### 2.1.2 Dual SPI

The device supports dual SPI operation with x2 and dual IO commands. These commands allow data to be transferred to or from the device at two times of rates of Standard SPI operation. The SI and the SO become bi-directional I/O pins: SIO0 and SIO1.

#### 2.1.3 Quad SPI

The device supports the x4 and Quad commands operation. These commands allow data to be transferred to or from the device at four times of rates of Standard SPI operation. The SI and the SO become bi-directional I/O pins: SIO0 and SIO1. The WP# and the HOLD# pins become SIO2 and SIO3. Once use the Quad SPI Mode, the Quad Enable (QE) bit of OTP register (B0[0]) must be set to 1<sup>[1]</sup>.

#### Note:

[1] Reference the Table 3-1 and the Table 5-1.

#### 2.2 Hold Mode

The HOLD# signal goes low to stop any serial communications with the device, but doesn't stop the operation of writing status register, programming or erasing in progress.

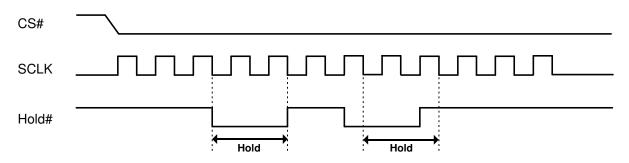


Figure 2-2. Hold Condition Diagram

#### Note:

Hold mode starts at the falling edge of HOLD# provided SCLK is also LOW. When SCLK is HIGH and HOLD# goes LOW, hold mode begins after the next falling edge of SCLK.

### 2.3 Write Protection Mode

Write protect (WP#) provides hardware protection mode. The WP# prevents the block lock bits (BP0, BP1, and BP2) from being overwritten. If the BRWD bit is set to 1 and WP# is LOW, the block protect bits cannot be altered.

## 3 Commands Description

Table 3-1. SPI NAND Command Set

Op Code	2 <sup>nd</sup> Byte	3 <sup>rd</sup> Byte	4 <sup>th</sup> Byte	5 <sup>th</sup> Byte	6 <sup>th</sup> Byte	N <sup>th</sup> Byte
04H	-	-	-	-	-	-
06H	-	-	-	-	-	-
D8H <sup>(3)</sup>	A23-A16	A15-A8	A7-A0	-	-	-
02H	A15-A8	A7-A0	D7-D0	Next data	Next data	-
32H	A15-A8	A7-A0	(D7-D0)x4	Next data	Next data	-
10H <sup>(3)</sup>	A23-A16	A15-A8	A7-A0	-	-	-
84H <sup>(1)</sup>	A15-A8	A7-A0	D7-D0	Next data	Next data	-
C4H/34H <sup>(1)</sup>	A15-A8	A7-A0	(D7-D0)x4	Next data	Next data	-
72H <sup>(1)(2)</sup>	A15-A0	(D7-D0)x4	Next data	Next data	Next data	-
13H <sup>(3)</sup>	A23-A16	A15-A8	A7-A0	-	-	-
03H/0BH	A15-A8	A7-A0	Dummy	D7-D0	Next data	Wrap
3BH	A15-A8	A7-A0	Dummy	(D7-D0)x2	Next data	Wrap
6BH	A15-A8	A7-A0	Dummy	(D7-D0)x4	Next data	Wrap
BBH	A15-A0	Dummy <sup>(4)</sup>	(D7-D0)x2	Next data	Next data	Wrap
EBH <sup>(2)</sup>	A15-A0	Dummy <sup>(5)</sup>	(D7-D0)x4	Next data	Next data	Wrap
9FH <sup>(3)</sup>	A7-A0	MID	DID	Wrap	Wrap	Wrap
FFH	-	-	-	-	-	-
0FH <sup>(3)</sup>	A7-A0	D7-D0	-	-	-	-
1FH <sup>(3)</sup>	A7-A0	D7-D0	-	-	-	-
	04H 06H 08H <sup>(3)</sup> 02H 32H 10H <sup>(3)</sup> 84H <sup>(1)</sup> C4H/34H <sup>(1)</sup> 72H <sup>(1)(2)</sup> 13H <sup>(3)</sup> 03H/0BH 3BH 6BH BBH EBH <sup>(2)</sup> 9FH <sup>(3)</sup> FFH 0FH <sup>(3)</sup>	04H - 06H - D8H <sup>(3)</sup> A23-A16 02H A15-A8 32H A15-A8 10H <sup>(3)</sup> A23-A16 84H <sup>(1)</sup> A15-A8 C4H/34H <sup>(1)</sup> A15-A8 72H <sup>(1)(2)</sup> A15-A0 13H <sup>(3)</sup> A23-A16 03H/0BH A15-A8 3BH A15-A8 BBH A15-A8 BBH A15-A0 EBH <sup>(2)</sup> A15-A0 9FH <sup>(3)</sup> A7-A0 FFH - 0FH <sup>(3)</sup> A7-A0	04H         -         -           06H         -         -           D8H <sup>(3)</sup> A23-A16         A15-A8           02H         A15-A8         A7-A0           32H         A15-A8         A7-A0           10H <sup>(3)</sup> A23-A16         A15-A8           84H <sup>(1)</sup> A15-A8         A7-A0           C4H/34H <sup>(1)</sup> A15-A8         A7-A0           72H <sup>(1)(2)</sup> A15-A0         (D7-D0)x4           13H <sup>(3)</sup> A23-A16         A15-A8           03H/0BH         A15-A8         A7-A0           3BH         A15-A8         A7-A0           6BH         A15-A8         A7-A0           BBH         A15-A0         Dummy <sup>(4)</sup> EBH <sup>(2)</sup> A15-A0         Dummy <sup>(5)</sup> 9FH <sup>(3)</sup> A7-A0         MID           FFH         -         -           0FH <sup>(3)</sup> A7-A0         D7-D0	04H         -         -         -           06H         -         -         -           D8H <sup>(3)</sup> A23-A16         A15-A8         A7-A0           02H         A15-A8         A7-A0         D7-D0           32H         A15-A8         A7-A0         (D7-D0)x4           10H <sup>(3)</sup> A23-A16         A15-A8         A7-A0           84H <sup>(1)</sup> A15-A8         A7-A0         D7-D0           C4H/34H <sup>(1)</sup> A15-A8         A7-A0         (D7-D0)x4           72H <sup>(1)(2)</sup> A15-A0         (D7-D0)x4         Next data           13H <sup>(3)</sup> A23-A16         A15-A8         A7-A0         Dummy           3BH         A15-A8         A7-A0         Dummy         Dummy           4BH         A15-A8         A7-A0         Dummy         Dummy           BBH         A15-A8         A7-A0         Dummy         (D7-D0)x2           EBH <sup>(2)</sup> A15-A0         Dummy <sup>(4)</sup> (D7-D0)x4           9FH <sup>(3)</sup> A7-A0         MID         DID           FFH         -         -         -           0FH <sup>(3)</sup> A7-A0         D7-D0         -	04H         -         -         -         -           06H         -         -         -         -           D8H <sup>(3)</sup> A23-A16         A15-A8         A7-A0         -         -           02H         A15-A8         A7-A0         D7-D0         Next data           32H         A15-A8         A7-A0         (D7-D0)x4         Next data           10H <sup>(3)</sup> A23-A16         A15-A8         A7-A0         -         -           84H <sup>(1)</sup> A15-A8         A7-A0         D7-D0         Next data         Next data           C4H/34H <sup>(1)</sup> A15-A8         A7-A0         (D7-D0)x4         Next data         Next data           72H <sup>(1)(2)</sup> A15-A0         (D7-D0)x4         Next data         Next data           13H <sup>(3)</sup> A23-A16         A15-A8         A7-A0         Dummy         D7-D0           3BH         A15-A8         A7-A0         Dummy         (D7-D0)x2           6BH         A15-A8         A7-A0         Dummy         (D7-D0)x4           BBH         A15-A0         Dummy <sup>(5)</sup> (D7-D0)x2         Next data           BBH         A15-A0         Dummy <sup>(5)</sup> (D7-D0)x4         Next data </td <td>04H         -</td>	04H         -

#### Note:

- 1. These commands are only available in Internal Data Move operation.
- 2. Quad Enable (QE) bit needs to be set to 1 when these commands are issued.
- 3. If QE = 1, do not make HOLD#/SIO3 = 0, when these commands are issued.
- 4. The number of dummy cycles is 4 cycles.
- 5. The number of dummy cycles is 2 cycles.

## 4 Write Operations

The WRITE ENABLE (WREN, 06H) command is for setting the Write Enable Latch (WEL) bit. The WRITE DISABLE (WRDI, 04H) command is for clearing the WEL bit.

As with any command that changes the memory contents, the WRITE ENABLE command must be executed at first in order to set the WEL bit to 1. For more information, please refer to the Page Read operation sequence, PAGE PROGRAM operation sequence, Internal Data Move operation sequence, BLOCK ERASE operation sequence and OTP operation sequence.

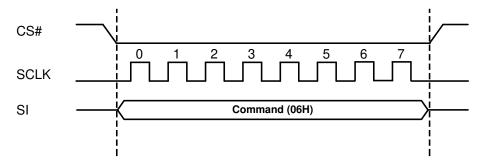


Figure 4-1. Write Enable (06H) Sequence Diagram

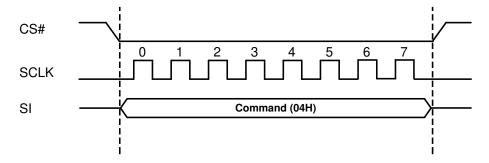


Figure 4-2. Write Disable (04H) Sequence Diagram

## 5 Feature Operations

The GET FEATURE (0FH) and SET FEATURE (1FH) commands are used to monitor the device status and alter the device behavior.

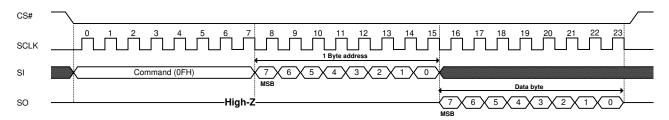
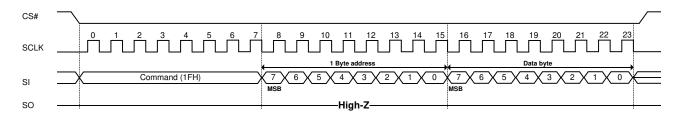


Figure 5-1. Get Feature (0FH) Sequence Diagram



Notes: If the status OIP = 1, the 'Set Feature (1FH)' command will be disable

Figure 5-2. Set Feature (1FH) Sequence Diagram

**Data Bits** Address Register 6 0  $\mathsf{BRWD}^{(\mathsf{R/W})}$  $\mathsf{INV}^{(\mathsf{R/W})}$ BP2<sup>(R/W)</sup> BP1<sup>(R/W)</sup> BP0<sup>(R/W)</sup> CMP<sup>(R/W)</sup> Block Lock A0H Reserved Reserved QE<sup>(R/W)</sup>  $\mathsf{ECC}_{-}\mathsf{EN}^{(\mathsf{R/W})}$  $\mathsf{OTP}\_\mathsf{EN}^{(\mathsf{R/W})}$ OTP\_PRT(R) OTP B0H Reserved Reserved Reserved Reserved ECCS1(R)  $\mathsf{OIP}^{(\mathsf{R})}$ ECCS0<sup>(R)</sup> P\_FAIL<sup>(R)</sup>  $\mathsf{E}_{-}\mathsf{FAIL}^{(\mathsf{R})}$  $\text{WEL}^{(R)}$ Status C0H Reserved Reserved

Table 5-1. Feature Register Table

#### Note:

- 1. (R/W): This bit can be read & programmed.
- 2. (R): This bit only can be read.
- 3. Reserved : Default value 0h.
- 4. The ECC status of register C0H will be cleared when ECC is disabled.
- 5. The default value of feature register is A0H=0x38 , B0H=0x10 , C0H=0x00.

## 6 Read Operations

### 6.1 Read ID (9FH)

The Read ID command is used to identify the SPI NAND. The Read ID command outputs the manufacturer ID with address byte 00H and outputs the device ID when address byte is 01H. If the SCLK keeps outputting, the SO will repeatedly outputs the MID/DID.

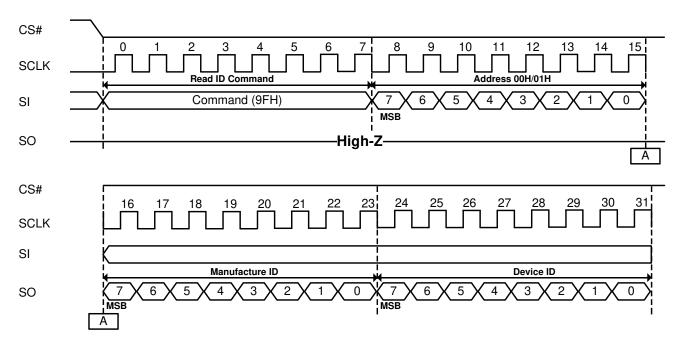


Figure 6-1. Read ID (9FH) Sequence Diagram

**Table 6-1. ID Definition Table** 

Address Byte	Value	R/W	Description
00h	D5h	R	Manufacturer ID: Etron
01h	8Ch	R	Device ID: EM78E044VCA-H

### 6.2 Page Read (13H)

The Page Read (13H) command transfers the data from the NAND array to the cache memory. The command sequence is described as follows:

- I. 13H (Page Read to Cache)
- II. 0FH (GET FEATURE command to read the status)
- III. Read from Cache memory
  - 03H or 0BH (Read from Cache x1 IO) / 3BH (Read from Cache x2 IO) / 6BH (Read from Cache x4 IO)
  - BBH (Read from Cache Dual IO) / EBH (Read from Cache Quad IO)

The Page Read command requires a 24-bit address consisting of dummy bits and block/page address bits, see the Table 6-2 definition. After the block/page addresses are registered, the device starts transferring from the main array to the cache register, and is busy for tRD time. During the busy time, the GET FEATURE command needs to be issued to monitor the status of Page Read. After finishing the Page Read successfully, the OIP bit in status register (C0H) will be set to 0. Then the Read from Cache command can be issued in order to read the data out of the cache.

The Read from Cache command requires 16 bits of column address which consists of wrap bits and column address bits, see the Table 6-3 definition. The number of bits of column address depends on the page size in different flash.

Table 6-2. 24-bit address consisting of dummy bits and block/page address bits

Row Address		24-Bits Address
Block	Dummy Bits	Page / Block Address Bits <sup>(1)</sup>
2048	RA<23:17>	RA<16:0>

Table 6-3. Wrap Bit Definition<sup>(2)</sup>

Wrap <2>	Wrap <1>	Wrap <0>	Wrap Length (Byte)
0	0	X	4352
0	1	X	4096
1	0	X	64
1	1	X	16

#### Note:

- 1. Please refer the Figure 1-2
- 2. Wrap bit has 3 bits and located at the first 3 bits in 16-bits column address.

### 6.2.1 Page Read to Cache (13H)

The waveform of Page Read to Cache (13H) is shown as follows:

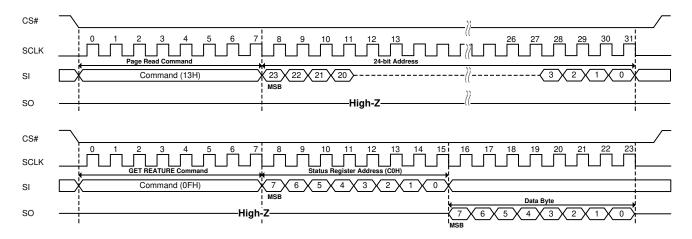


Figure 6-2. Page Read to Cache (13H) Sequence Diagram

### 6.3 Read from Cache x1 IO (03H/0BH)

The Read from Cache x1 IO (03H/0BH) consists of an OP code followed by 16-bit column address. The column address is composed of wrap bits and column address bits. Refer the Read from Cache x1 IO sequence diagram as follows:

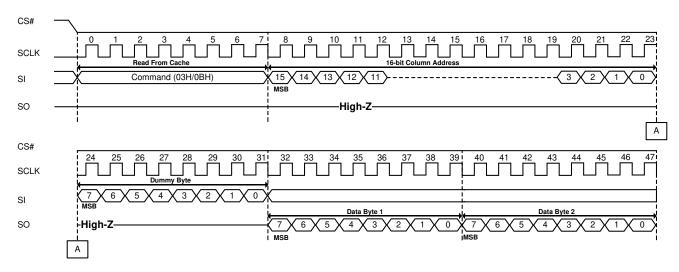


Figure 6-3. Read from Cache x1 IO (03H/0BH) Sequence Diagram

### 6.4 Read from Cache x2 IO (3BH)

The Read from Cache x2 IO (3BH) command is similar to the Read from Cache x1 IO (03H/0BH) but the command uses two pins to output data. The data output pins include the SI (SIO0) and the SO (SIO1). The Read from Cache x2 IO (3BH) sequence diagram is shown as follows:

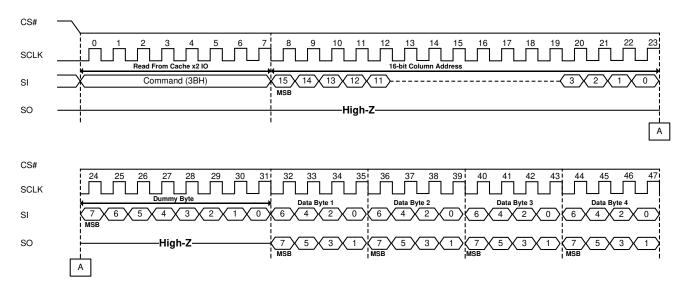


Figure 6-4. Read from Cache x2 IO (3BH) Sequence Diagram

### 6.5 Read from Cache x4 IO (6BH)

The Read from Cache x4 IO (6BH) command is similar to the Read from Cache x1 IO (03H/0BH) and the Read from Cache x2 IO (3BH) but the command uses four pins to output data. The four pins include the SI (SIO0), SO (SIO1), WP# (SIO2) and HOLD# (SIO3). The Read from Cache x4 IO (6BH) sequence diagram is shown as follows:

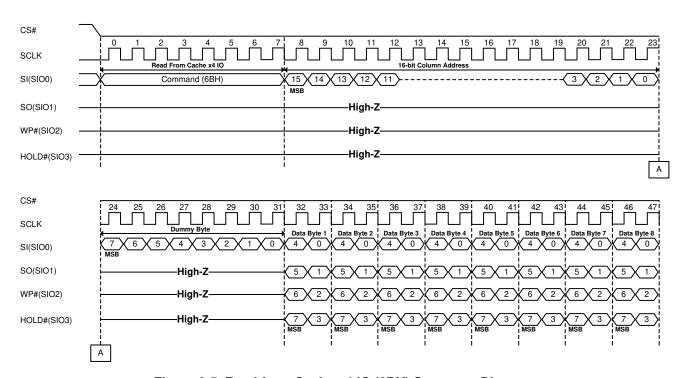


Figure 6-5. Read from Cache x4 IO (6BH) Sequence Diagram

#### 6.6 Read from Cache Dual IO (BBH)

The Read from Cache Dual IO command (BBH) is similar to the Read from Cache x2 IO command (3BH) and uses both of SI (SIO0) and SO (SIO1) as input bin. Each bit in 16-bit column address and the followed dummy byte will be latched in during the falling edge of SCLK, then the cache contents will be shifted out 2-bit in a clock cycle through the SI (SIO0) and the SO (SIO1).

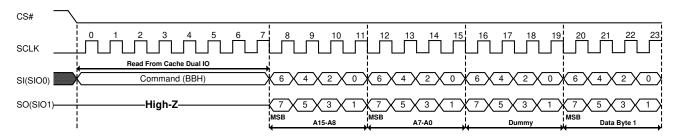


Figure 6-6. Read from Cache Dual IO (BBH) Sequence Diagram

#### 6.7 Read from Cache Quad IO (EBH)

The Read from Cache Quad IO (EBH) command is similar to the Read from Cache x4 IO (6BH) command and has 4 input pins which are SI (SIO0), SO (SIO1), WP# (SIO2) and HOLD# (SIO3). Each bit in 16-bit column address and the followed dummy byte will be latched in during the raising edge of SCLK through these four input pins, and then the cache contents will be shifted out 4-bit in a clock cycle through SI (SIO0), SO (SIO1), WP# (SIO2) and HOLD# (SIO3) The Quad Enable bit (QE) of OTP register (B0[0]) must be set to enable the Read from Cache Quad IO (EBH) command .

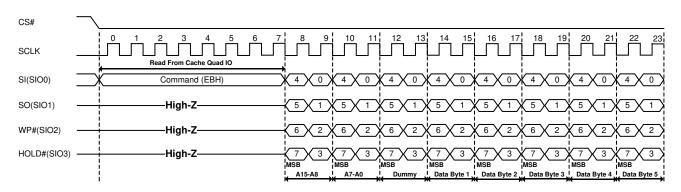


Figure 6-7. Read from Cache Quad (EBH) Sequence Diagram

### 7 Program Operations

The PAGE PROGRAM sequence transfers the data from the host to NAND flash array through cache memory. The operation sequence programs the first byte to last byte of data within a page. If page size is not enough, those additional bytes will be ignored by the cache memory. The PAGE PROGRAM sequence is as follows:

- I. 06H (WRITE ENABLE when WEL bit is 0)
- II. PROGRAM LOAD
  - 02H (PROGRAM LOAD) / 32H (PROGRAM LOAD x4)
- III. 10H (PROGRAM EXECUTE)
- IV. 0FH (GET FEATURE command to read the status)

At first, the WRITE ENABLE (06H) command is used to set the Write Enable Latch (WEL) bit. The Write Enable Latch (WEL) bit must be set prior to issuing a program execute (10h). The PROGRAM LOAD (02H/32H) command is issued then and the PROGRAM LOAD command can only be issued one time in a PAGE PROGRAM sequence. Secondly, the PROGRAM EXECUTE (10H) command is issued to program the data into the page. During the busy time, the GET FEATURE command needs to be issued to monitor the status of PAGE PROGRAM. After finishing the PAGE PROGRAM successfully, the OIP and WEL bit in status register (C0H) will be set to 0.

### 7.1 Program Load (PL) (02H)

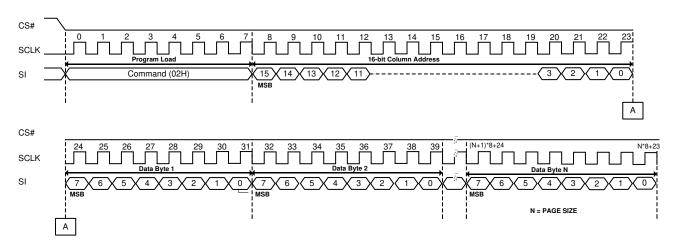


Figure 7-1. Program Load (02H) Sequence Diagram

### 7.2 Program Load x4 IO (PL x4) (32H)

The PROGRAM LOAD x4 IO (32H) command is similar to the PROGRAM LOAD (02H) command and uses four input pins to transfer data in. The four input pins are SI (SIO0), SO (SIO1), WP# (SIO2) and HOLD# (SIO3). The Quad Enable bit (QE) of OTP register (B0[0]) must be set to enable the PROGRAM LOAD x4 IO (32H) command. The command sequence is shown as follows:

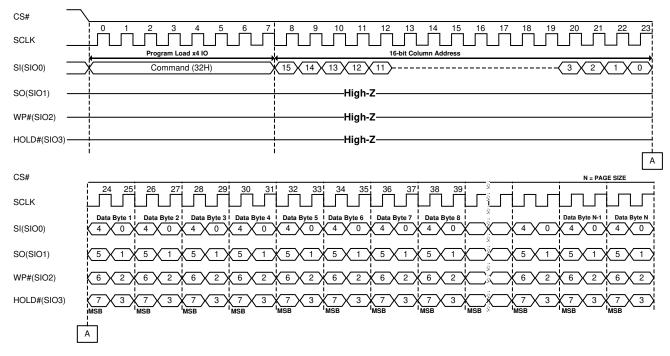


Figure 7-2. Program Load x4 IO (32H) Sequence Diagram

### 7.3 Program Execute (PE) (10H)

PROGRAM EXECUTE (10H) command must be issued after the data is loaded and the WEL bit is set to HIGH. The PROGRAM EXECUTE (10H) command will transfer data from the cache to the main array. The PROGRAM EXECUTE (10H) consists of an 8-bit Op code, followed by a 24-bit address which including dummy bits and page/block address. This operation needs to wait the busy time. The OIP bit in status register (C0H) will be HIGH until controller finishes the program. The P\_FAIL bit in status register (C0H) will be set HIGH if program fail.

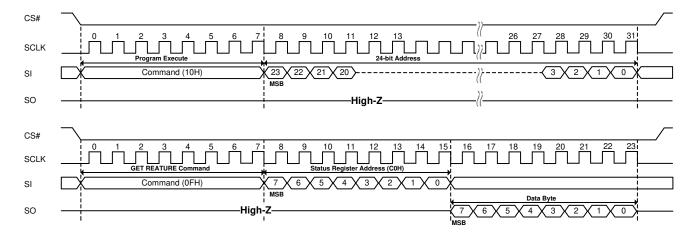


Figure 7-3. Program Execute (10H) Sequence Diagram

### 8 Internal Data Move

The Internal Data Move sequence programs or replaces data in a page with existing data. The Internal Data Move operation sequence is as follows:

- I. 13H (Page Read to cache)
- II. 0FH (GET FEATURE command to read the status).
- III. Optional 84H/C4H/34H/72H (PROGRAM LOAD RANDOM DATA. The command of Program load random data can be operated several times in this step.)
- IV. 06H (WRITE ENABLE)
- V. 10H (PROGRAM EXECUTE)
- VI. 0FH (GET FEATURE command to read the status)
  - 84H/C4H/34H/72H commands are only available in Internal Data Move operation.

### 8.1 Program Load Random Data (84H)

Program Load Random Data (84H) command consists of an OP code, followed by 16 bit column address which includes dummy bits and column address bits. This command can only be used in Internal Data Move sequence.

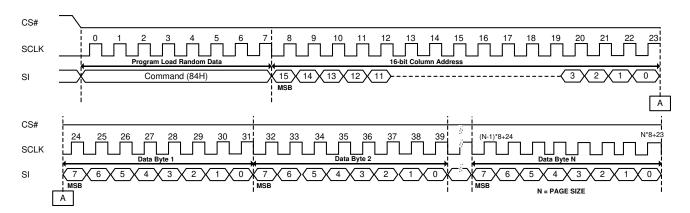


Figure 8-1. Program Load Random Data (84H) Sequence Diagram

### 8.2 Program Load Random Data x4 (C4H/34H)

The Program Load Random Data x4 (C4H/34H) command is similar to the Program Load Random Data Command (84H) and has four input pins. The four input pins are SI(SIO0), SO(SIO1), WP#(SIO2) and HOLD#(SIO3). The Quad Enable bit needs to be set before the Program Load Random Data x4 command be used. The command is only available during the Internal Data Move sequence.

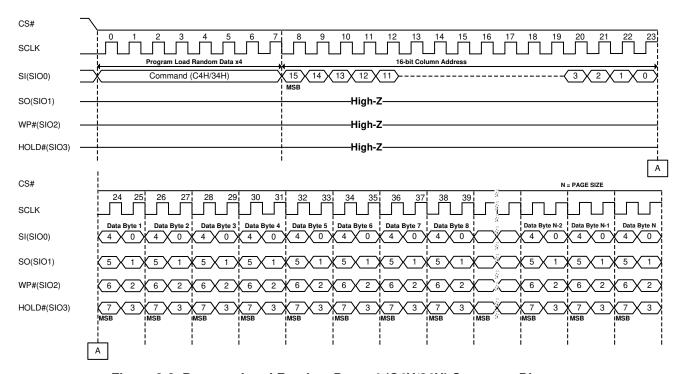


Figure 8-2. Program Load Random Data x4 (C4H/34H) Sequence Diagram

### 8.3 Program Load Random Data Quad IO (72H)

The Program Load Random Data Quad IO (72H) is similar to the Program Load Random Data x4 (C4H/34H) command and has 4 input pins: SI(SIO0), SO(SIO1), WP#(SIO2) and HOLD#(SIO3). The Quad Enable (QE) bit in feature register (B0[0]) needs to be set to 1 for the Program Load Random Data Quad IO command. This command is only available during Internal Data Move sequence.

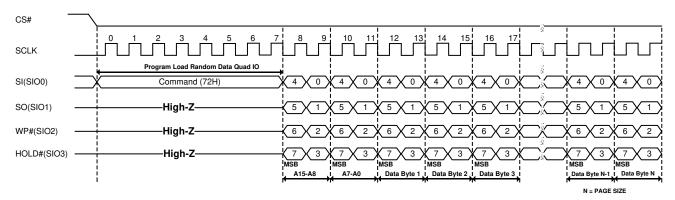


Figure 8-3. Program Load Random Data Quad IO (72H) Sequence Diagram

### 9 Erase Operation- Block Erase (D8H)

The BLOCK ERASE (D8H) command is used to erase at block level. The command sequence for BLOCK ERASE operation is as follows:

- I. 06H (WRITE ENABLE command)
- II. D8H (BLOCK ERASE command)
- III. 0FH (GET FEATURE command to read the status register)

Erase Operation sequence starts from a WRITE ENABLE (06H) command to set WEL bit to 1. After executing the WRITE ENABLE command, BLOCK ERASE (D8H) command can be issued. BLOCK ERASE (D8H) requires a 24-bit address which consists of dummy bits and row address (page address in row address will be ignored automatically). Issue the GET FEATURE (0FH) command to monitor the erase operation after issuing the BLOCK ERASE. The E\_FAIL bit in status register can reflect whether the block be erased successfully or not.

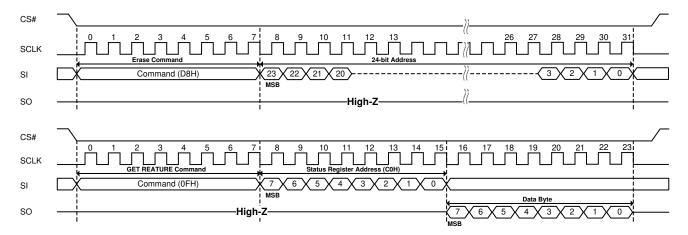


Figure 9-1. Block Erase (D8H) Sequence Diagram

## 10 Reset Operation - Reset (FFH)

The RESET (FFH) command stops all operations. For example, the RESET command can stop the previous operation and the pending operations during a cache program or a cache read command.

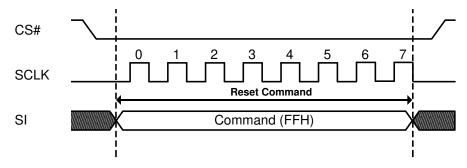


Figure 10-1. Reset (FFH) Sequence Diagram

## 11 One-Time Programmable (OTP) Function

#### 11.1 OTP Definition

The serial device offers a protected, OTP area. 63 full pages are available on the device. Users can use the OTP area any way they want, like programming serial numbers, or other data, for permanent storage. When delivered from factory, feature bit OTP\_PRT is 0.

Table 11-1, OTP State

OTP_PRT	OTP_EN	State				
Χ	0	ormal operation. Cannot access the OTP region.				
0	1	Access OTP region. PAGE READ and PAGE PROGRAM are allowed.				
		The OTP_PRT has two situations when the device power on,				
		1. OTP_PRT is 0 when the device power on: User can use SET FEATURE command to set the				
1	1	OTP_PRT and OTP_EN bit to 1, and then issue PROGRAM EXECUTE (10H) to lock OTP region.				
		Once the OTP region was locked, the OTP_PRT will permanently be 1.				
		2. OTP_PRT is 1 when the device power on: user can only read the OTP region data.				

#### **Table 11-2. OTP Page Definition**

Page Address	Page Name	Description	Data Length	Notes
004	Parameter Page	Factory Dynamana and Danid Only	050 Ditto * 4	
00h	OTP Page [0]	Factory Programmed , Read Only	256 Bytes * 4	
01h 2Eh	OTD Dogo [1:62]	Read & Program when OTP_PRT=0	4 252 Putos	
01h ~ 3Fh	OTP Page [1:63]	Read Only when OTP_PRT=1	4,352 Bytes	

### How to access to OTP region:

- 1. Issue the GET FEATUTE command (0FH).
- 2. Set Feature bit OTP EN.
- 3. Issue the PAGE READ command or PAGE PROGRAM command. The PAGE PROGRAM command can be allowed only when OTP\_PRT is 0. The PAGE READ command will automatically be ignored if OTP\_PRT is 1.

#### How to protect OTP region:

Only when the following steps are completed, the OTP\_PRT will be set to 1.

- 1. Issue the SET FEATURE (1FH) command.
- 2. Set feature bit OTP\_EN and OTP\_PRT.
- 3. 06H (WRITE ENABLE)
- 4. Issue the PROGRAM EXECUTE (10H) command.
- 5. Issue the GET FEATURE (0FH) command to wait the device goes to ready state from busy.

### 11.2 Parameter Page Definition

Table 11-3. Parameter Page Data Structure

	Parameter Page Data Structure							
Address (DEC)	Description	Display	VALUE					
0~3	Parameter page signature	ASCII	4Fh, 4Eh, 46h, 49h					
4~5	ONFI Revision number	HEX	00h, 00h					
6~7	Features supported	HEX	00h, 00h					
8~9	Optional commands supported	HEX	06h, 00h					
10~31	Reserved (0)	HEX	ALL 00h					
32~43	Device manufacturer (12 Bytes ASCII characters)	ASCII	45h, 74h, 72h, 6Fh, 6Eh, 20h, 20h, 20h, 20h, 20h, 20h, 20h					
	Device model (20Bytes ASCII characters)							
44~63	EM78E044VCA-H		45h, 4Dh, 37h, 38h, 45h, 30h, 34h, 34h, 56h, 43h, 41h, 2Dh, 48h, 20h, 20h, 20h, 20h, 20h, 20h, 20h, 20					
64	JEDEC manufacturer ID	HEX	D5h					
65~66	Date code	HEX	00h, 00h					
67~79	Reserved (0)	HEX	ALL 00h					
80~83	Number of data bytes per page	HEX	00h, 10h, 00h, 00h					
84~85	Number of spare bytes per page	HEX	00h, 01h					
86~89	Number of data bytes per partial page	HEX	00h, 00h, 00h, 00h					
90~91	Number of spare bytes per partial page	HEX	00h, 00h					
92~95	Number of pages per block	HEX	40h, 00h, 00h, 00h					
96~99	Number of blocks per logical unit (LUN)	HEX	00h, 10h, 00h, 00h					
100	Number of logical units (LUNs)	HEX	01h					
101	Number of address cycles	HEX	00h					
102	Number of bits per cell	HEX	01h					
103~104	Bad blocks maximum per LUN	HEX	50h, 00h					
105~106	Block endurance	HEX	06h, 04h					
107	Guaranteed valid blocks at beginning of target	HEX	01h					
108~109	Block endurance for guaranteed valid blocks	HEX	00h, 00h					
110	Number of programs per page	HEX	01h					
111	Partial programming attributes	HEX	00h					
112	Number of bits ECC correctability	HEX	08h					
113	Number of interleaved address bits	HEX	00h					
114	Interleaved operation attributes	HEX	00h					
115~127	Reserved (0)	HEX	ALL 00h					
128	I/O pin capacitance	HEX	00h					
129~130	Timing mode support	HEX	00h, 00h					
131~132	Program cache timing mode support	HEX	00h, 00h					
133~134	tPROG Maximum page program time (us)	HEX	BCh, 02h					
135~136	tBERS Maximum block erase time (us)	HEX	B8h, 0Bh					
137~138	tR Maximum page read time (us)	1	8Ch, 00h					
139~140	tCCS Minimum change column setup time (ns)	HEX	00h, 00h					
141~163	Reserved (0)	HEX	ALL 00h					
164~165	Vendor specific Revision number	HEX	00h, 00h					
166~253	Vendor specific	HEX	ALL 00h					
254~255	Integrity CRC	HEX	(SEE THE NOTES 1)					
256~511	Value of Address 0~255	HEX	Same as address 0~255					
512~767	Value of Address 0~255	HEX	Same as address 0~255					
768~1023	Value of Address 0~255	HEX	Same as address 0~255					
1024+	Additional redundant parameter pages	HEX	ALL FFh					

Note 1: (Source : ONFI\_1.0\_GOLD)

The CRC shall be calculated using the following 16-bit generator polynomial :  $G(X) = X^{16} + X^{15} + X^2 + 1$ 

The CRC calculation covers all of data between byte 0 and byte 253 of the parameter page inclusive.

This polynomial in hex may be represented as 8005h.

The CRC value shall be initialized with a value of 4F4Eh before the calculation begins.

### 12 Block Protection

The block lock feature provides the ability to protect the entire device, or ranges of blocks, from the PROGRAM and ERASE commands. After power-up, the device is in the "locked" state, i.e., feature bits BP0, BP1 and BP2 are set to 1, INV, CMP and BRWD are set to 0. Some block operations relating to the block protection are listed as follows:

- SET FEATURE command must be issued to alter the state of protection feature bit.
- When BRWD is set and WP# is LOW, none of the writable protection feature bits can be set.
- When a PROGRAM/ERASE command is issued to a locked block, status bit OIP in status register (C0H) remains 0. The status register (C0H) will return 08H when a PROGRAM command is issued to program a locked block. The status register (C0H) will return 04H when an ERASE command is issued to erase a locked block.
- When WP# is not LOW, user can issue SET FEATURE command and use the protection register (A0H) and the block protect bits table below to alter the protection rows.

**Table 12-1. Block Protection Bits Table** 

СМР	INV	BP2	BP1	BP0	Protect Rows
Х	Х	0	0	0	All unlocked
0	0	0	0	1	Upper 1/64 locked
0	0	0	1	0	Upper 1/32 locked
0	0	0	1	1	Upper 1/16 locked
0	0	1	0	0	Upper 1/8 locked
0	0	1	0	1	Upper 1/4 locked
0	0	1	1	0	Upper 1/2 locked
Х	Х	1	1	1	All locked (Default)
0	1	0	0	1	Lower 1/64 locked
0	1	0	1	0	Lower 1/32 locked
0	1	0	1	1	Lower 1/16 locked
0	1	1	0	0	Lower 1/8 locked
0	1	1	0	1	Lower 1/4 locked
0	1	1	1	0	Lower 1/2 locked
1	0	0	0	1	Lower 63/64 locked
1	0	0	1	0	Lower 31/32 locked
1	0	0	1	1	Lower 15/16 locked
1	0	1	0	0	Lower 7/8 locked
1	0	1	0	1	Lower 3/4 locked
1	0	1	1	0	Block 0
1	1	0	0	1	Upper 63/64 locked
1	1	0	1	0	Upper 31/32 locked
1	1	0	1	1	Upper 15/16 locked
1	1	1	0	0	Upper 7/8 locked
1	1	1	0	1	Upper 3/4 locked
1	1	1	1	0	Block 0

## 13 Status Register

The content of status register can be read by issuing the GET FEATURE (0FH) command, followed by the status register address C0H. The meaning of each bit in status register is listed as follows:

Table 13-1. Status Register Bit Description

Bit	Name	Description		
		This bit indicates that a program failure has occurred. It will also be set if the		
D FAII	Dua 200 - 5 - 9	user attempts to program an invalid address or a protected region, including the		
P_FAIL	Program Fail	OTP area. This bit is cleared during the PROGRAM EXECUTE command		
		sequence or a RESET command.		
		This bit indicates that an erase failure has occurred. It will also be set if the user		
E_FAIL	Erase Fail	attempts to erase a locked region. This bit is cleared at the start of the BLOCK		
		ERASE command sequence or the RESET command.		
		This bit indicates that the current status of the write enable latch(WEL) and must		
WEL	Write Enable Latch	be set (WEL = 1), prior to issuing a PROGRAM EXECUTE or BLOCK ERASE		
VVEL		command. It is set by issuing the WRITE ENABLE command. WEL can also		
		disabled (WEL = 0), by issuing the WRITE DISABLE command.		
		This bit is set when a PROGRAM EXECUTE, PAGE READ, BLOCK ERASE of		
OIP	Operation In Progress	RESET command is executing, indicating the device is busy. When the bit is 0,		
		the interface is in the ready state.		
		This bit provides ECC status as follows:		
		00b = No bit errors were detected		
		01b = bit error was detected and corrected		
		10b = bit error was detected and not corrected		
ECCS1, ECCS0	ECC Status	11b = bit error was detected and corrected, error bit number = ECC max which		
		is according to extended register.		
		ECCS is set to 00b either following a RESET, or at the beginning of the READ. It		
		is then updated after the device completes a valid operation. After power-on		
		RESET, ECC status is set to reflect the contents of block 0, page 0.		

Notes: The ECC status of register C0H will be cleared when ECC is disabled.

### 14 Block Management

A NAND Flash device is specified to have a minimum number of valid blocks of the total available blocks per die, which means the devices may have blocks that are invalid when shipped from the factory. The factory identifies invalid blocks before shipping by attempting to program the bad-block mark into every location in the first page of each invalid block. It may not be possible to program every location in an invalid block with the bad-block mark but the first spare area location in each bad block is guaranteed to contain the bad-block mark. System software should initially check the first spare area location for non-FFh data on the first page of each block prior to performing any program or erase operations on the NAND Flash device.

**Table 14-1. Valid Block Information** 

Total available blocks	2048
Minimum number of valid blocks	2008
The bad block mark	All 00h

### 15 Power-On Process

When the chip reached the power on level, the internal power on reset signal will be released. The device can response host commands after tPUW (Max 4ms). The host should issue GET FEATURE (0Fh). The device will use the OIP bit in the status register to inform the host that initialization in power-on process is completed. Setting OIP bit to 1 indicates that the device is still initializing. Setting the OIP bit to 0 indicates that the power on process is finished. If OIP bit is 1, the host will repeatedly issues GET FEATURE (0Fh) command to monitor the power-on process until the OIP bit is set to 0.

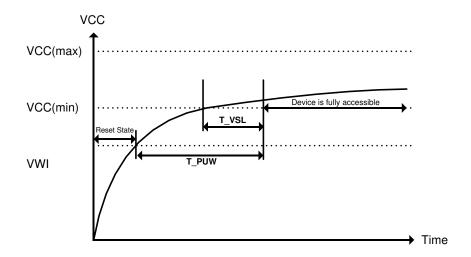


Figure 15-1. Power-On Process

**Table 15-1. Power-On Process Parameters** 

Parameters		Symbol	Min	Typical	Max	Unit
VCC (min) to CS# Low		tVSL	50	-	500	us
Time Delay Before Read/Write Instruction		tPUW	-	3	4	ms
Write Inhibit Threshold Voltage	1.8V	vWI	1.5	-	-	V

## 16 Electrical Characteristics

**Table 16-1. Capacitance Characteristics** 

Parameters	Symbol	Min	Typical	Max	Unit	Condition
Input Capacitance	CIN	-	-	3.5	pF	VIN=0V
Output Capacitance	COUT	-	-	3.5	pF	VOUT=0V
Load Capacitance	CL		10		pF	
Input Rise and Fail time		-	-	5	ns	

Table 16-2. 1.8V SPI NAND DC Characteristics

Parameters	Symbol	Min	Typical	Max	Unit
SPI Supply Voltage	VCC	1.7	1.8	1.98	V
VCC standby current	ISB	-	30	120	uA
VCC active current (sequential read)	ICC1	-	20	30	mA
VCC active current (Program)	ICC2	-	20	30	mA
VCC active current (Erase)	ICC3	-	25	30	mA
Input low level	V_IL	-0.3	-	0.2 x VCC	V
Input high level	V_IH	0.8 x VCC	-	VCC + 0.3	V
Output High Voltage	V_OH	VCC - 0.2	-	-	V
Output Low Voltage	V_OL	-	-	0.2	V
Input Leakage Current	I_LI	-	-	±10	uA
Output Leakage Current	I_LO	-	-	±10	uA

Table 16-3. 1.8V AC Time Characteristics ( $T_A = -40 \sim 85^{\circ}C$ ,  $C_L = 10pF$ )

Parameters	Symbol	Min	Typical	Max	Unit
Clock Frequency	FC	-	-	100	MHz
Page Program Time	tPROG	-	600	700	us
Clock High Time	tCLH	5	-	-	ns
Clock Low Time	tCLL	5	-	-	ns
Command deselect Time	tSHSL	20			ns
CS# Setup Time	tSLCH	4	-	-	ns
CS# Hold Time	tCHSL	4	-	-	ns
Data In Setup Time	tDVCH	2	-	-	ns
Data In Hold Time	tCHDX	4	-	-	ns
Output Hold time	tCLQX	2.7	-	-	ns
Clock to output Valid	tCLQV	-	-	9.5	ns
CS# High to Output Invalid	tSHQZ	-	-	4	ns
CS# Active Hold time relative to SCLK	tCHSH	4	-	-	ns
CS# Not Active Setup time relative to SCLK	tSHCH	4	-	-	ns
Hold# hold time relative to SCLK	tCH	5	-	-	ns
Hold# non-active hold time relative to SCLK	tCD	5	-	-	ns
Hold# setup time relative to SCLK	tHD	5	-	-	ns
Hold# non-active setup time relative to SCLK	tHC	5	-	-	ns
Hold# to output High-Z	tHZ	-	-	10	ns
Hold# to output Low-Z	tLZ	-	-	10	ns
WP# setup time	tWPS	20	-	-	ns
WP# hold time	tWPH	100	-	-	ns

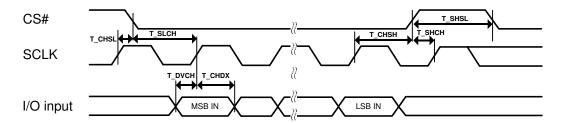


Figure 16-1. Serial Input Timing

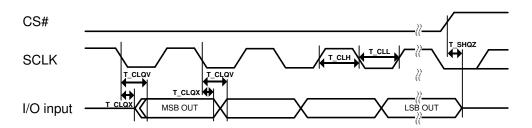


Figure 16-2. Serial Output Timing

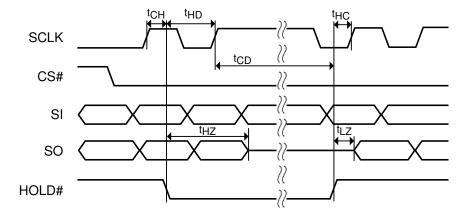


Figure 16-3. Hold# Timing

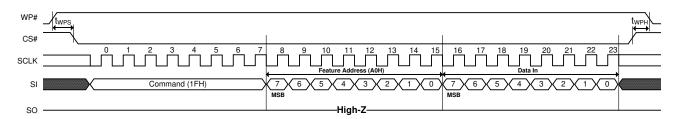


Figure 16-4. WP# Timing

## 17 Package Outline Information

Table 17-1. LGA (8 x 6 x 0.8mm) Dimension Table

Symbol	Dimension (MM)			Dimension (MIL)		
	Min	Nom	Max	Min	Nom	Max
Α	0.700	0.750	0.800	27.559	29.528	31.496
(A1)	0.500	0.550	0.600	19.685	21.654	23.622
A2	-	0.210	-	-	8.268	-
b	0.350	0.400	0.480	13.780	15.748	18.898
D	7.900	8.000	8.100	311.023	314.960	318.897
E	5.900	6.000	6.100	232.283	236.220	240.157
е		1.270	•	50.000		
L	0.450	0.500	0.550	17.717	19.685	21.654

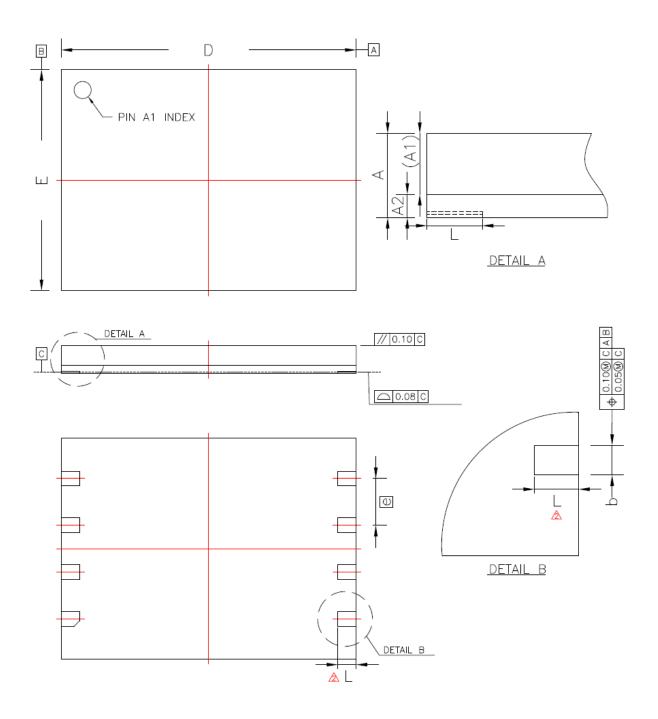


Figure 17-1. LGA (8 x 6 x 0.8mm) Package Outline Drawing Information